

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10767182	PILLAI ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Hoang, Hieu T	2452	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	217, 219	11/26/2007	HH
709	242, 249, 250	9/20/2011	HH
718	108	9/20/2011	HH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (US PAT, US PGPUB)	11/26/2007	HH
NPL (Google, IETF, IEEE)	11/26/2007	HH
EAST (US PAT, US PGPUB)	9/8/2009	HH
EAST (US PAT, US PGPUB)	1/13/2010	HH
EAST (US PAT, US PGPUB)	5/9/2010	HH
EAST (US PAT, US PGPUB)	10/5/2010	HH
EAST (US PAT, US PGPUB)	5/25/2011	HH
EAST (US PAT, US PGPUB)	9/20/2011	HH
PLUS	9/20/2011	HH
Double patenting	9/20/2011	HH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
Interference search in EAST		9/20/2011	HH

	/HIEU HOANG/ Primary Examiner.Alt Unit 2452
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